IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent	t Application of)			
	ANTONELLI et al) Group Art Unit: Unassigned			
_	n No.: Unassigned) Examiner: Unassigned			
	tober 31, 2003) Confirmation No.: Unassigned			
For: A DI	NON-DESTRUCTIVE METHOD OF ETECTING DEFECTS IN BRAZE- EPAIRED CRACKS				
INFORMATION DISCLOSURE STATEMENT TRANSMITTAL LETTER					
P.O. Box	oner for Patents 1450 a, VA 22313-1450				
Sir:					
	nclosed is an Information Disclosure Solutified patent application.	Statement and accompanying form PTO-1449 for the			
[3	-	No additional fee for submission of an IDS is required.			
[The fee of \$180.00 (1806) as se	The fee of \$180.00 (1806) as set forth in 37 C.F.R. § 1.17(p) is also enclosed.			
[] A statement under 37 C.F.R. §	A statement under 37 C.F.R. § 1.97(e) is also enclosed.			
[A statement under 37 C.F.R. § in 37 C.F.R. § 1.17(p) are also	A statement under 37 C.F.R. § 1.97(e), and the fee of \$180.00 (1806) as set forth in 37 C.F.R. § 1.17(p) are also enclosed.			
ſ] Charge \$to Dep	Charge \$to Deposit Account No. 02-4800 for the fee due.			
	[] A check in the amount of \$ is enclosed for the fee due.				
1 17 and	The Director is hereby authorized to Cl	harge any appropriate fees under 37 C.F.R. §§ 1.16, ber, and to credit any overpayment, to Deposit			
	Respec	etfully submitted,			
	Burns	S, DOANE, SWECKER & MATHIS, L.L.P.			
Date: _	October 31, 2003 By:	Robert S. Swecker Registration No. 19,885			
	ox 1404 Iria, Virginia 22313-1404 36-6620				

BADEN / SWITZERLAND

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN THE COURT		
In re application of		
Giampiero Antonelli, An	dreas Boegli , Klaus Germe	rdonk, Alexander Schnell (inventors)
		(IIIVelliois)
claiming Priority under 3	5 U.S.C. 119	
of application No.:	02405932.1	
in:	Europe	
with filing date of:	2002-10-31	
U.S. Serial Number:		
U.S. filing date:		
Title: A non-destructiv	e method of detecting defec	cts in braze-repaired cracks
		ENT UNDER 37 CFR 1.97
Honorable Commission	er of Patents and Trademar	ks, Washington, D.C. 20231
Sir:		
Submitted herewith is a foreign patent applicati	Search Report/Examination	n Report issued in a corresponding
•		
European Patent Office German Patent Office	()	
	_ ()	
We wish to make Examination Report in	of record the certain citation accordance with 37 CFR 1	ns listed in the Search Report/ .97.
	each listed item with regard ccording to the opinion of th in the Search Report/Exami	I to the different claims of the above- le Search Authority/Examination nation Report
/ tationty , to maississ		Lander Donort shoot

by reference to certain categories which are explained on the Report sheet or in MPEP on page 1800 - 55, resp. (x)

3.	The claims as filed in the above-ident	ified U.S. patent application
corresp	oond to	()
are diff	erent from	(x)
	ims for which the Search Report/Exar stablished.	nination Report has
4.	Copies of the references cited are en	closed herewith.
All cita	•	(x)
All rele	vant citations except U.S. patents	()
6. charac indicat	English translations of pertinent portion of herewith, if such translation is read to copies are enclosed herewith of resterized by an "A" in the Search Reportes that such reference is not relevant anally, copies of the references in the specification are enclosed.	eferences, which are t/Examination Report, since "A"
Date:	2003-10-21	Respectfully submitted, Andreas Weiland

Substitute for forms 1449A/PTO & 1449B/PTO

FIRST INFORMATION DISCLOSURE STATEMENT BY APPLICANT

ATTORNEY'S DKT NO. 033275-413	APPLICATION NO. Unassigned
APPLICANT Giampiero ANTONELLI et al	
FILING DATE	GROUP Unassigned

Examiner item (Initials	Kind Code (if known)	Name of Patentee or of Cited Docum Chesnes et al White et al Konter et al Konter et al Harris et al Chasteen Reverman Chasteen OREIGN PATENT DOCUMENTS Country WO	ment (MM-DD-YYY 09-09-199 03-31-199 03-30-199 06-02-199 02-17-198 03-17-199 12-10-199			
5,666,643 5,732,467 5,888,451 5,759,301 4,643,782 4,188,237 5,728,227 5,071,486 Examiner Initials Document Number 01/22076 885489 0034041 Examiner Initials In item (item (item)	Kind Code	White et al Konter et al Konter et al Harris et al Chasteen Reverman Chasteen OREIGN PATENT DOCUMENTS	03-31-199 03-30-199 06-02-199 02-17-198 02-12-198 12-10-199 12-10-199			
5,732,467 5,888,451 5,759,301 4,643,782 4,188,237 5,728,227 5,071,486 Examiner Document Number 01/22076 885489 0034041	Kind Code	Konter et al Konter et al Harris et al Chasteen Reverman Chasteen OREIGN PATENT DOCUMENTS	03-30-199 06-02-199 02-17-198 02-12-198 03-17-199 12-10-199 S Date of Publication (MM-DD-YYYY) Translation (MM-DD-YYYY)			
5,888,451 5,759,301 4,643,782 4,188,237 5,728,227 5,071,486 Examiner Initials Document Number 01/22076 885489 0034041 Examiner Initials In item (Kind Code	Konter et al Harris et al Chasteen Reverman Chasteen OREIGN PATENT DOCUMENTS	06-02-199 02-17-198 02-12-198 03-17-199 12-10-199			
5,759,301 4,643,782 4,188,237 5,728,227 5,071,486 Examiner Initials Document Number 01/22076 885489 0034041 Examiner Initials In item (Kind Code	Harris et al Chasteen Reverman Chasteen OREIGN PATENT DOCUMENTS	02-17-198 02-12-198 03-17-199 12-10-199 S Date of Publication (MM-DD-YYYY) Translation (MM-DD-YYYY)			
## 4,643,782 ## 4,188,237 ## 5,728,227 ## 5,071,486 Examiner Initials	Kind Code	Chasteen Reverman Chasteen OREIGN PATENT DOCUMENTS Country	02-12-198 03-17-199 12-10-199 S Date of Publication (MM-DD-YYYY) Translation (MM-DD-YYYY)			
Examiner Initials Document Number 01/22076 885489 0034041	Kind Code	Reverman Chasteen OREIGN PATENT DOCUMENTS Country	03-17-199 12-10-199 Date of Publication (MM-DD-YYYY) Yes			
Examiner Initials Document Number 01/22076 885489 0034041 Examiner Initials In item (Kind Code	Chasteen OREIGN PATENT DOCUMENTS Country	Date of Publication (MM-DD-YYYY) Yes			
Examiner Initials Document Number 01/22076 885489 0034041 Examiner Initials In item (Kind Code	OREIGN PATENT DOCUMENTS Country	Date of Publication Transla (MM-DD-YYYY) Yes			
Initials Number	Kind Code	Country	Date of Publication Transla (MM-DD-YYYY) Yes			
Initials Number	Kind Code	Country	Date of Publication Transla (MM-DD-YYYY) Yes			
Initials Number			(MM-DD-YYYY) Yes			
01/22076 885489 0034041 Examiner Initials	(If Khown)		(1,11,13,14,14,14,14,14,14,14,14,14,14,14,14,14,			
885489 0034041 Examiner Initials			1 03-23-2001 1			
Examiner Initials		DE	08-06-1953			
Examiner item (EP EP	03-20-1985			
Examiner item (Initials						
Examiner item (Initials						
Examiner item (Initials		PATENT LITERATURE DOCUM				
	book, magazine, jo	nor (in CAPITAL LETTERS), title of the ar ournal, serial, symposium, catalog, etc.), of publisher, city and/or country where	date, page(s), volume-issue number(s), published.			
vol. 35, no. 6, pa	Rao et al, "An artificial neural network for eddy current testing of austenitic stainless steel welds", NDT & E International, vol. 35, no. 6, pages 393-398 (2002), Elsevier Science Ltd, Butterworth-Heinemann, Oxford, Great Britain, XP 004365970. Burke, "Crack depth measurement using Eddy-Current NDE", pages 1-10, presented at Destructive Testing, Sept. 17-21,					
2001, Brisbane,	Australia.	requestly Seepping Eddy Current Equipm	ment For Nondestructive Characterization of			
and Serviced Hi	Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of a Frequency Scanning Eddy Current Equipment For Nondestructive Characterization of New Antonelli et al, "Qualification of Association of Associa					
Antonelli et al, "I Advanced Coati	Antonelli et al, "Non-Destructive Condition Assessment of Serviced MCrAIY Coatings, presented at Turbine Forum on Advanced Coatings for High Temperatures, Nice, France, pages 1-12.					

Examiner	Date	
Signature	Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.